## Notice of References Cited

Application/Control No. 09/514,119 .	Reexamination	Applicant(s)/Patent Under Reexamination SCHNECK ET AL.		
Examiner	Art Unit			
Kaveh Abrishamkar	2131	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,935,248 A	08-1999	Kuroda, Yasutsugu	713/201
	В	US-5,164,938 A	11-1992	Jurkevich et al.	370/231
	С	US-6,510,349 B1	01-2003	Schneck et al.	700/9
	D	US-6,108,583 A	08-2000	Schneck et al.	700/9
	Е	US-5,477,531 A	12-1995	McKee et al.	370/249
	F	US-5,689,566 A	11-1997	Nguyen, Minhtam C.	713/155
	G	US-5,793,763 A	08-1998	Mayes et al.	370/389
	Н	US-6,257,486 B1	07-2001	Teicher et al.	235/380
	. 1	US-			
	J	US-			
	к	US-		•	
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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